

Search Notes



Application/Control No.

10/776,291

Examiner

John S. Chu

Applicant(s)/Patent under Reexamination

OHSAWA ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	170	11/2005	jc
430	270.1		
430	326		
430	905		
534	558		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
430	170,270.1	11/2005	jc
430	329,905		
534	558		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST SEARCH UPDATED	11/2005	jc
INVENTOR SEARCH UPDATED		